

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10629033	MAYO ET AL.
	Examiner Wai, Eric C	Art Unit 2195

SEARCHED

Class	Subclass	Date	Examiner
709	229, 219	03/07/07	ECW
713	324	03/07/07	ECW
600	407	03/07/07	ECW

SEARCH NOTES

Search Notes	Date	Examiner
Inventor's Name Search	03/07/07	ECW
East Search	03/07/07	ECW

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner